

Notice of References Cited	Application/Control No. 10/670,212	Applicant(s)/Patent Under Reexamination NAKAYAMA ET AL.	
	Examiner Matthew D. Matzek	Art Unit 1771	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	JP 09059882	03-1997	Japan	Yoneda et al.	D06N 003/14
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NON-PATENT DOCUMENTS

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